# Silicon N Channel Power MOS FET Power Switching

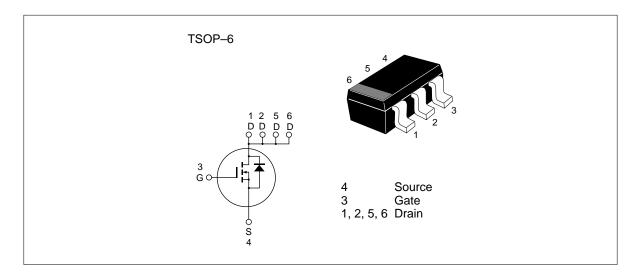
# **HITACHI**

ADE-208-756B(Z) Preliminary, 3rd. Edition Dec. 1, 1998

### **Features**

- Low on-resistance
- Low drive current
- High density mounting
- 4.5V gate drive device can be driven from 5V source

#### **Outline**



# **Absolute Maximum Ratings** (Ta = 25°C)

Item	Symbol	Ratings	Unit	
Drain to source voltage	V <sub>DSS</sub>	30	V	
Gate to source voltage	V <sub>GSS</sub>	±20	V	
Drain current	I <sub>D</sub> *2	6.3	A	
Drain peak current	I <sub>D(pulse)</sub> *1	25.2	A	
Body-drain diode reverse drain current	*2	6.3	A	
Channel dissipation	Pch <sub>(pulse)</sub> *2	2.0	W	
	Pch <sub>(continuous)</sub> *3	1.05	W	
Channel temperature	Tch	150	°C	
Storage temperature	Tstg	-55 to +150	°C	

Notes: 1. PW  $\leq$  10 $\mu$ s, duty cycle  $\leq$  1 %

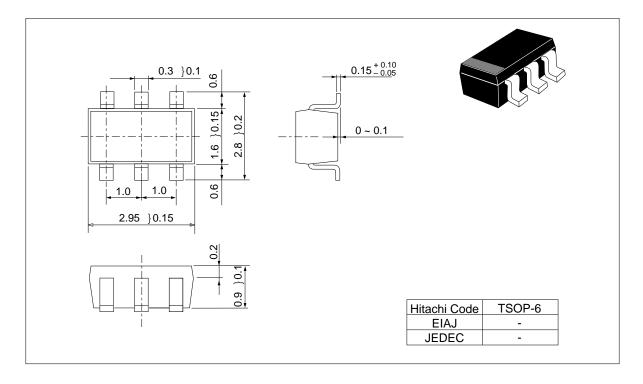
- 2. When using the alumina ceramic board (50 x 50 x 0.7 mm), PW $\leq$  5s,Ta=25°C
- 3. When using the alumina ceramic board (50 x 50 x 0.7 mm) , $Ta=25^{\circ}C$

### **Electrical Characteristics** (Ta = 25°C)

Item	Symbol	Min	Тур	Max	Unit	Test Conditions
Drain to source breakdown voltage	$V_{(BR)DSS}$	30	_	_	V	$I_{D} = 10 \text{mA}, V_{GS} = 0$
Gate to source leak current	I <sub>GSS</sub>		_	±0.1	μΑ	$V_{GS} = \pm 20V, V_{DS} = 0$
Zero gate voltage drain current	I <sub>DSS</sub>	_	_	1	μΑ	$V_{DS} = 30 \text{ V}, V_{GS} = 0$
Gate to source cutoff voltage	$V_{GS(off)}$	1.0	_	2.5	V	$V_{DS} = 10V$ , $I_D = 1mA$
Static drain to source on state	R <sub>DS(on)</sub>		26	31	mΩ	$I_D = 3A, V_{GS} = 10V^{*1}$
resistance	R <sub>DS(on)</sub>	_	40	52	mΩ	$I_D = 3A, V_{GS} = 4.5V^{*1}$
Forward transfer admittance	y <sub>fs</sub>	4	7	_	S	$I_D = 3A, V_{DS} = 10V^{*1}$
Input capacitance	Ciss	_	620	_	pF	V <sub>DS</sub> = 10V
Output capacitance	Coss	_	170	_	pF	$V_{GS} = 0$
Reverse transfer capacitance	Crss	_	110	_	pF	f = 1MHz
Turn-on delay time	t <sub>d(on)</sub>		13	_	ns	$V_{GS} = 10V, I_{D} = 3A$
Rise time	t <sub>r</sub>	_	90	_	ns	$R_L = 3.3\Omega$
Turn-off delay time	t <sub>d(off)</sub>	_	50	_	ns	_
Fall time	t <sub>f</sub>	_	40	_	ns	
Body-drain diode forward voltage	V <sub>DF</sub>	_	0.95	_	V	IF = 6.3A, $V_{GS} = 0^{*1}$
Body-drain diode reverse recovery time	t <sub>rr</sub>		(50)		ns	$IF = 6.3A, V_{GS} = 0$ diF/ dt =20A/ $\mu$ s
Notes 4 District						

Note: 1. Pulse test

## **Package Dimensions (Unit: mm)**



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